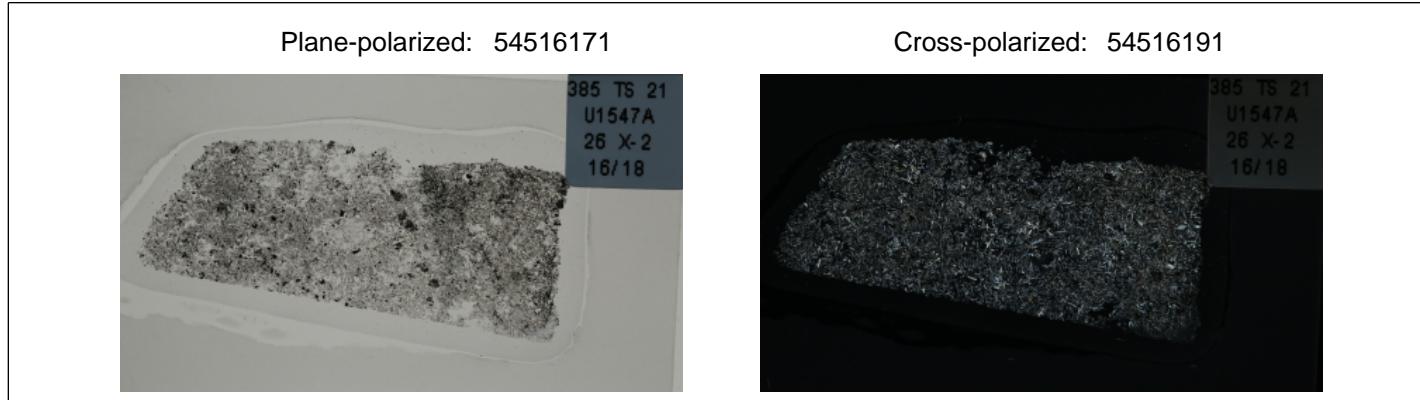


THIN SECTION LABEL ID:	385-U1547A-26X-2-W 16/18-TSB-TS 21	Thin section no.: 21
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty, 5% pyrite GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: moderately vesicular ALTERATION: highly altered VEINS: absent	
	Comments: haloed alteration is always chlorites	



Igneous Petrology

Lithology:	aphyric basalt sill				Groundmass grain size (avg.):	fine-grained [NMJ05]		
Texture:	aphyric				Grain size distribution:	equigranular		
Groundmass								
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	60	50	10	0.1	0.8	euhedral	elongate	
Clinopyroxene	30	5	25	0.1	0.5	subhedral	elongate	
Vesicle								
Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
				1	3	angular		

Alteration

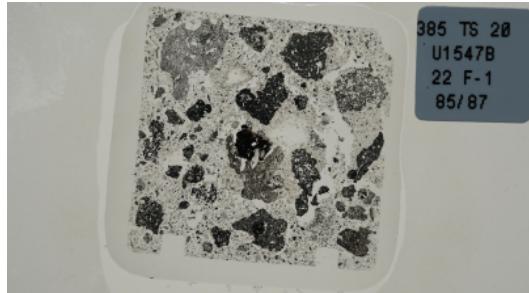
Alteration intensity:	highly altered	Texture of Alteration	patchy	Recrystallization extent:	strong [recrust]
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THIN SECTION LABEL ID: 385-U1547B-22F-1-W 85/87-TSB-TS 20

Thin section no.: 20

Observer: km

Plane-polarized: 54570491



Cross-polarized: 54570511



Sediments and Sedimentary Rock

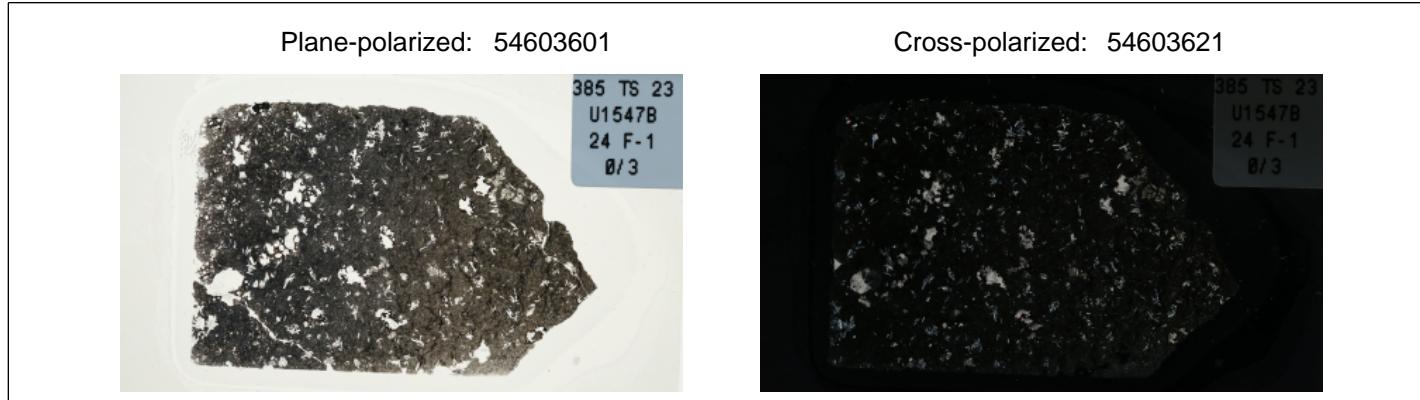
Lithology: sand

TEXTURE	Percent	CONSTITUENT	Percent
Sand		Siliciclastic Grains/Mineral	92
Silt		Authigenic Minerals	2
Clay		Biogenic Grains	6
Total Texture		Total Constituent	100

Framework grain abundance

Component	%	Component	%	Component	%
Quartz		Ferromagnesium minerals	1	Vitric Grains	
Feldspar		Opaque Minerals	1	Foraminifera	6
Plagioclase	20	Zeolite	2	Radiolarians	
Rock Fragments	70	Pyrite		Diatoms	
Igneous Volcanic Fragments		Quartz (Authigenic)		Organic Debris	
Sedimentary Fragments		Calcite		Plant Debris	
Matrix (Silt and Clay)		Dolomite		Fish Remains	
Biotite		Porosity		Other	
Clay Minerals					

THIN SECTION LABEL ID:	385-U1547B-24F-1-W 0/3-TSB-TS 23	Thin section no.: 23
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: plagioclase phryic basalt sill GROUNDMASS: fine-grained, felty, 3% pyrite GRAIN SIZE DISTRIBUTION: Bimodal TEXTURE: porphyritic PHENOCRYSTS: 5% plagioclase, 1% clinopyroxene VESICLES: moderately vesicular ALTERATION: highly altered	



Igneous Petrology

Lithology: plagioclase phryic basalt sill Groundmass grain size (avg.): fine-grained [NMJ05]
 Texture: porphyritic Grain size distribution: Bimodal

Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	5	3	2	0.4	0.8	euhedral	elongate	
Clinopyroxene	1	0.5	0.5	0.2	0.5	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	1	4	0.1	2	subrounded		

Alteration

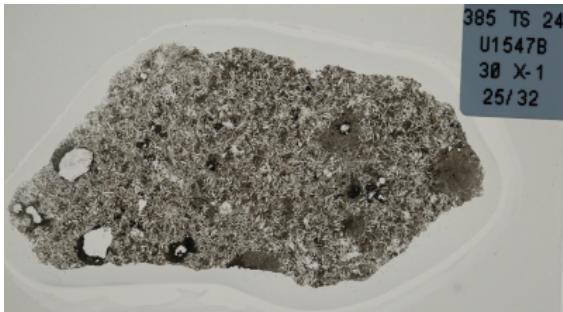
Alteration intensity: intensely altered Texture of Alteration: coating Recrystallization extent: strong [recrust]

THIN SECTION LABEL ID: 385-U1547B-30X-1-W 25/32-TSB-TS 24
Observer: Wei Xie

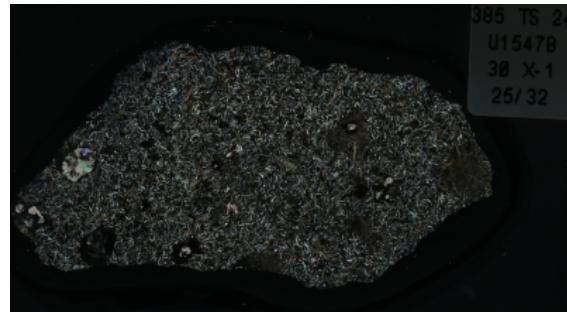
Thin section no.: 24

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty, 2% pyrite GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: sparsely vesicular ALTERATION: moderately altered

Plane-polarized: 54603641



Cross-polarized: 54603661



Igneous Petrology

Lithology:	aphyric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	aphyric	Grain size distribution:	equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	60	50	10	0.2	0.5	euhedral	elongate	
Clinopyroxene	35	15	20	0.1	0.5	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	3	0	3	0.5	2	rounded		

Alteration

Alteration intensity:	moderately altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recryst]
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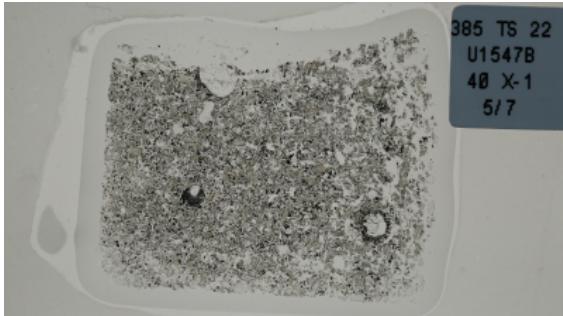
THIN SECTION LABEL ID: 385-U1547B-40X-1-W 5/7-TSB-TS 22

Thin section no.: 22

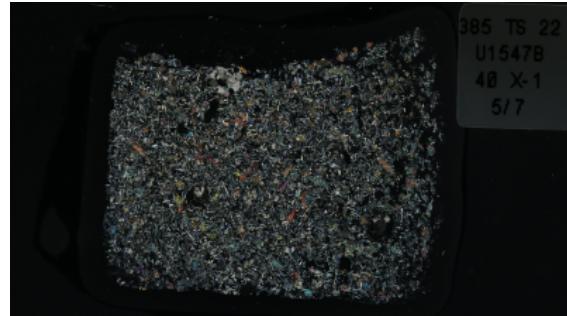
Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty, 3% pyrite GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: sparsely vesicular ALTERATION: highly altered VEINS: absent

Plane-polarized: 54521091



Cross-polarized: 54521231



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	65	60	5	0.1	1	euhedral	elongate	
Clinopyroxene	30	20	10	0.1	1	subhedral	equant	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	1	1	0.3	1	subrounded		

Alteration

Alteration intensity: slightly altered

Texture of Alteration

patchy

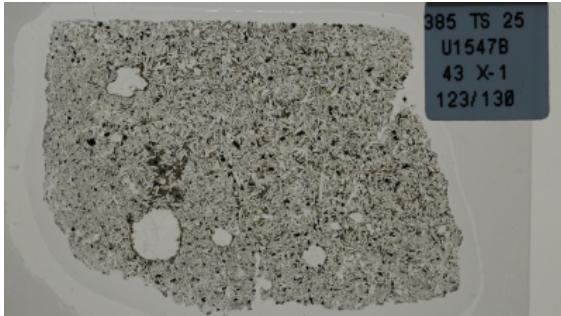
Recrystallization extent: weak [recryst]

THIN SECTION LABEL ID: 385-U1547B-43X-1-W 123/130-TSB-TS 25
Observer: Wei Xie

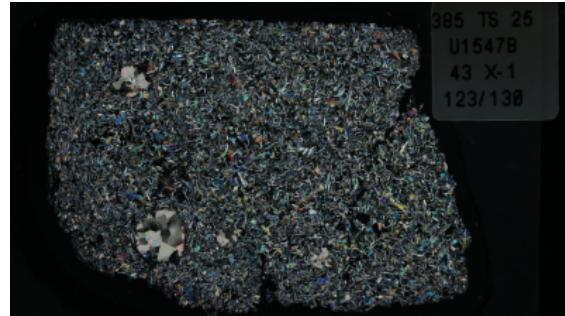
Thin section no.: 25

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty, 5% pyrite GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: sparsely vesicular ALTERATION: slightly altered

Plane-polarized: 54613951



Cross-polarized: 54613971



Igneous Petrology

Lithology:	aphyric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	aphyric	Grain size distribution:	equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	65	63	2	0.2	0.8	euhedral	elongate	
Clinopyroxene	30	20	10	0.2	0.6	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	0	2	1	4	subrounded		

Alteration

Alteration intensity:	slightly altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recryst]
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THIN SECTION LABEL ID: **385-U1547B-45X-1-W 47/55-TSB-TS 26**

Thin section no.: 26

Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: none ALTERATION: highly altered

Plane-polarized: 54605161



Cross-polarized: 54605181



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	25	25	0.2	0.8	euhedral	elongate	
Clinopyroxene	40	10	30	0.1	0.6	subhedral	elongate	

Alteration

Alteration intensity: highly altered

Texture of Alteration

patchy

Recrystallization extent:

strong
[recryst]

THIN SECTION LABEL ID: 385-U1547B-50X-1-W 60/74-TSB-TS 27
Observer: Wei Xie

Thin section no.: 27

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular TEXTURE: aphyric PHENOCRYSTS: none VESICLES: none ALTERATION: moderately altered

Plane-polarized: 54605201



Cross-polarized: 54605221



Igneous Petrology

Lithology:	aphyric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	aphyric	Grain size distribution:	equigranular

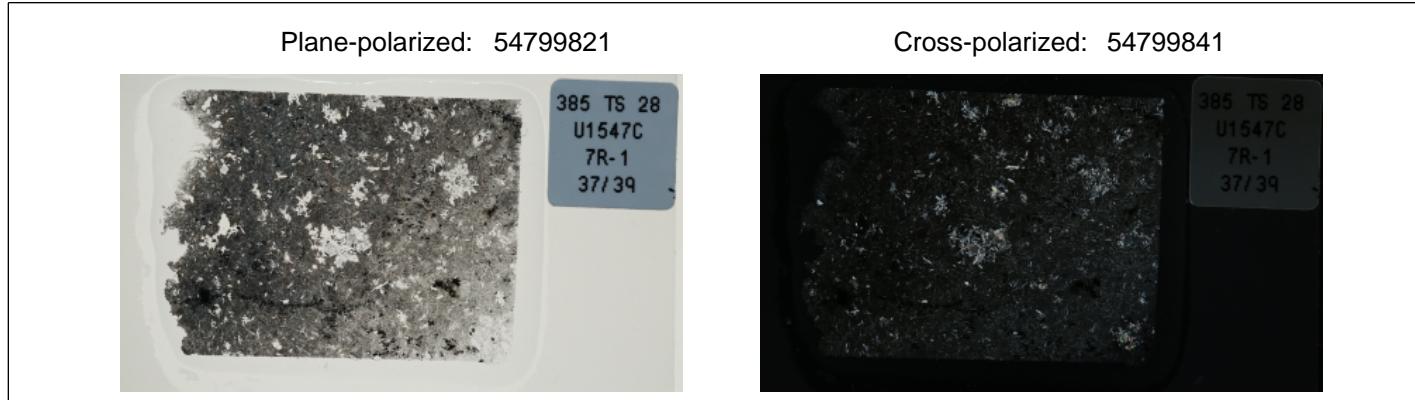
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	65	60	5	0.2	1	euhedral	elongate	
Clinopyroxene	30	15	15	0.1	0.5	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	1	1	0	0.5	2	rounded		

Alteration

Alteration intensity:	moderately altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recryst]
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THIN SECTION LABEL ID:	385-U1547C-7R-1-W 37/39-TSB-TS 28	Thin section no.: 28
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: plagioclase clinopyroxene phryic basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: Bimodal TEXTURE: porphyritic PHENOCRYSTS: 10% plagioclase + 5% clinopyroxene VESICLES: none ALTERATION: highly altered Comments: host rock	



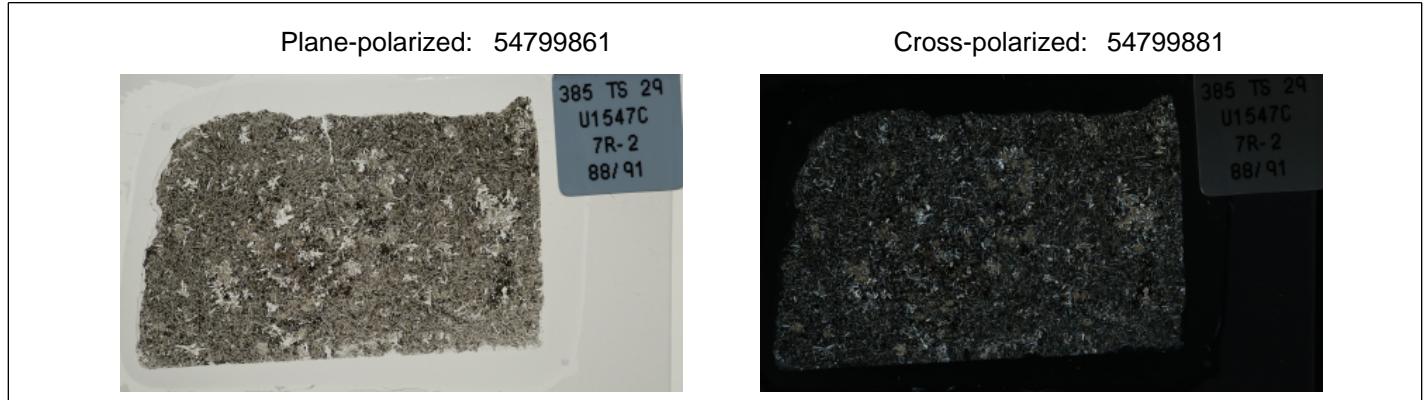
Igneous Petrology

Lithology:	plagioclase clinopyroxene phryic basalt sill				Groundmass grain size (avg.):	fine-grained [NMJ05]		
Texture:	porphyritic				Grain size distribution:	Bimodal		
Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	20	15	5	0.5	1	euhedral	elongate	
Clinopyroxene	5	2	3	0.4	0.5	subhedral	elongate	
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	40	20	20	0.2	0.5	euhedral	elongate	
Clinopyroxene	30	2	28					

Alteration

Alteration intensity:	intensely altered	Texture of Alteration	coating	Recrystallization extent:	strong [recrust]
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THIN SECTION LABEL ID:	385-U1547C-7R-2-W 88/91-TSB_XRF_XRD-TS 29	Thin section no.: 29
Observer:	Wei Xie	
Thin section summary:	<p>LITHOLOGY: plagioclase clinopyroxene phryic basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: Bimodal TEXTURE: porphyritic PHENOCRYSTS: 5% plagioclase + 3% clinopyroxene VESICLES: none ALTERATION: highly altered</p> <p>Comments: host rock</p>	



Igneous Petrology

Lithology:	plagioclase clinopyroxene phryic basalt sill				Groundmass grain size (avg.):	fine-grained [NMJ05]		
Texture:	porphyritic				Grain size distribution:	Bimodal		
Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	5	4	1	0.5	1	euhedral	elongate	
Clinopyroxene	3	0	3	0.3	0.5	subhedral	elongate	
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	30	20	0.1	0.3	euhedral	elongate	
Clinopyroxene	40	10	30	0.1	0.2	subhedral	elongate	

Alteration

Alteration intensity:	highly altered	Texture of Alteration	coating	Recrystallization extent:	strong [recrust]
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THIN SECTION LABEL ID: 385-U1547C-8R-1-W 16/20-TSB-TS 30

Thin section no.: 30

Observer: km

Plane-polarized: 54799901



Cross-polarized: 54799961



Sediments and Sedimentary Rock

Lithology: sand

TEXTURE	Percent	CONSTITUENT	Percent
Sand		Siliciclastic Grains/Mineral	73
Silt		Authigenic Minerals	10
Clay		Biogenic Grains	6
Total Texture		Total Constituent	94

Framework grain abundance

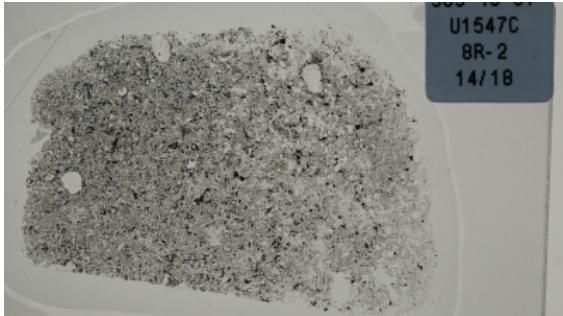
Component	%	Component	%	Component	%
Quartz		Ferromagnesium minerals	5	Vitric Grains	5
Feldspar		Opaque Minerals	2	Foraminifera	5
Plagioclase	5	Zeolite		Radiolarians	
Rock Fragments		Pyrite		Diatoms	
Igneous Volcanic Fragments	10	Quartz (Authigenic)		Organic Debris	
Sedimentary Fragments	50	Calcite	10	Plant Debris	
Matrix (Silt and Clay)		Dolomite		Fish Remains	1
Biotite	1	Porosity		Other	
Clay Minerals					

THIN SECTION LABEL ID: 385-U1547C-8R-2-W 14/17-TSB_XRD_XRF-TS31 Thin section no.: 31

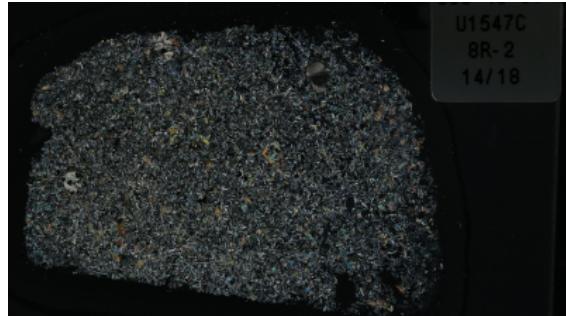
Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 55% pl+40% cpx+5% pyrite TEXTURE: aphyric PHENOCRYSTs: none VESICLES: 2% ALTERATION: slightly altered

Plane-polarized: 54799981



Cross-polarized: 54800001



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	55	50	5	0.5	1	euhedral	elongate	
Clinopyroxene	40	30	10	0.3	0.8	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	0	2	0.5	1	subrounded		

THIN SECTION LABEL ID: 385-U1547D-5R-1-W 44/46-TSB-TS 34

Thin section no.: 34

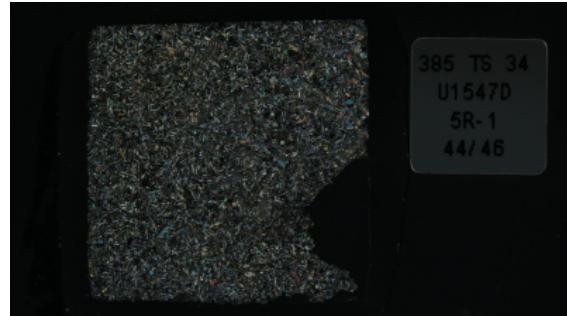
Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 60% pl+40% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 2% ALTERATION: slightly altered

Plane-polarized: 54903791



Cross-polarized: 54903811



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	60	55	5	0.2	0.5	euhedral	elongate	
Clinopyroxene	40	20	20	0.1	0.3	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	1	1	0.2	0.5	subrounded		

Alteration

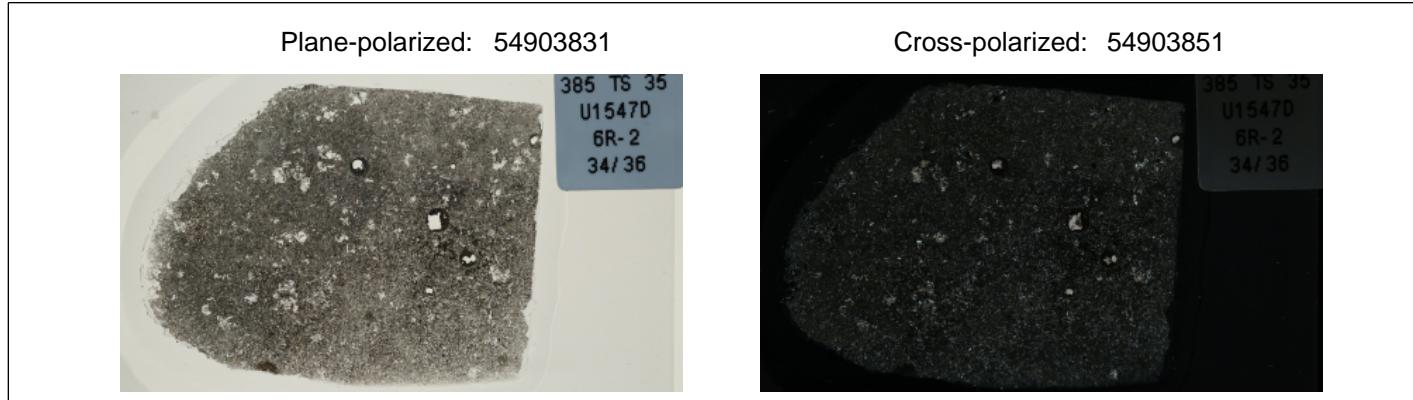
Alteration intensity: slightly altered

Texture of Alteration

patchy

Recrystallization extent: weak [recryst]

THIN SECTION LABEL ID:	385-U1547D-6R-2-W 34/36-TSB-TS 35	Thin section no.: 35
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: plagioclase clinopyroxene phryic basalt sill GRAIN SIZE DISTRIBUTION: Bimodal TEXTURE: porphyritic PHENOCRYSTS: 5% plagioclase + 3% clinopyroxene VESICLES: 2% ALTERATION: highly altered Comments:	



Igneous Petrology

Lithology:	plagioclase clinopyroxene phryic basalt sill				Groundmass grain size (avg.):	fine-grained [NMJ05]		
Texture:	porphyritic				Grain size distribution:	Bimodal		
Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	3	2	1	0.4	0.8	euhedral	elongate	
Clinopyroxene	1	0	1	0.4	0.6	subhedral	elongate	
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	30	20	0.1	0.4	euhedral	elongate	
Clinopyroxene	39	4	35	0.1	0.3	subhedral	elongate	
Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	0	2	0.3	0.8	subrounded		

Alteration

Alteration intensity:	highly altered	Texture of Alteration	coating	Recrystallization extent:	strong [recrust]
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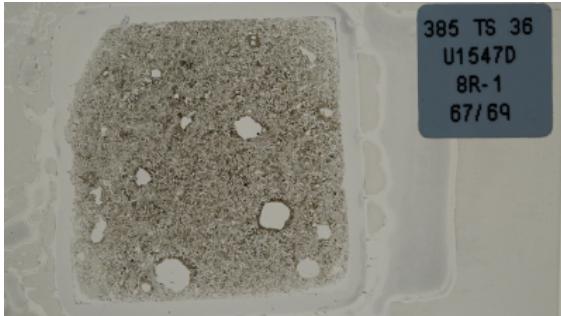
THIN SECTION LABEL ID: 385-U1547D-8R-1-W 67/69-TSB-TS 36

Thin section no.: 36

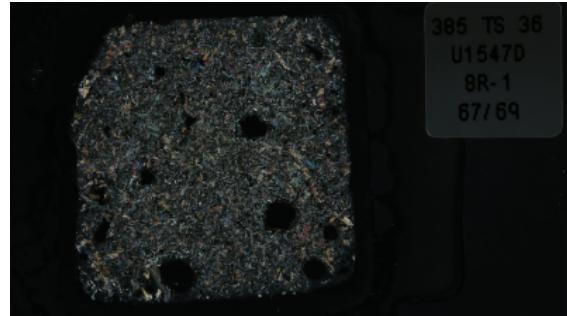
Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 50% pl+50% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 5% ALTERATION: slightly altered

Plane-polarized: 54903871



Cross-polarized: 54903891



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	45	5	0.5	1	euhedral	elongate	
Clinopyroxene	50	30	20	0.4	1	euhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	4	1	0.2	1	rounded		

Alteration

Alteration intensity: slightly altered

Texture of Alteration

patchy

Recrystallization extent: weak [recryst]

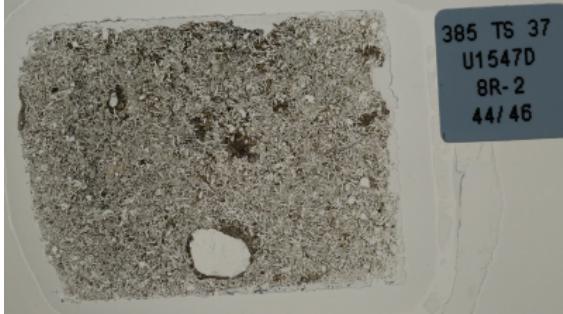
THIN SECTION LABEL ID: 385-U1547D-8R-2-W 44/46-TSB-TS 37

Thin section no.: 37

Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 50% pl+50% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 1% ALTERATION: slightly altered

Plane-polarized: 54903911



Cross-polarized: 54903931



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	50	50	0.5	1	euhedral	elongate	
Clinopyroxene	50	30	20	0.5	1	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	1	0	1	0.5	4	subrounded		

Alteration

Alteration intensity: slightly altered

Texture of Alteration

patchy

Recrystallization extent: weak [recrust]

THIN SECTION LABEL ID:

385-U1547D-12R-1-W 122/124-TSB-TS 38

Thin section no.: 38

Observer:

Wei Xie

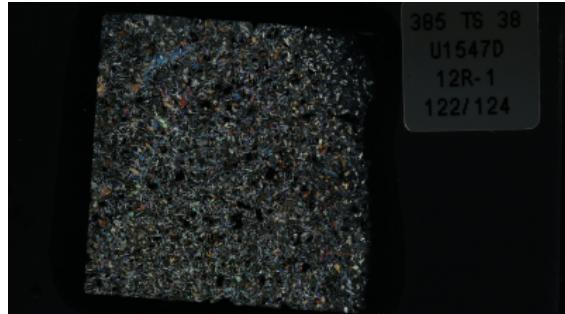
Thin section summary:

LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 40% pl + 50% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 10% ALTERATION: slightly altered

Plane-polarized: 55023761



Cross-polarized: 55023781



Igneous Petrology

Lithology: aphyric basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: aphyric

Grain size distribution: equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	40	40	0	0.5	1	euhedral	elongate	
Clinopyroxene	50	30	20	0.5	1	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	10	8	2	0.3	1	subangular		

Alteration

Alteration intensity: slightly altered

Texture of Alteration

patchy

Recrystallization extent:

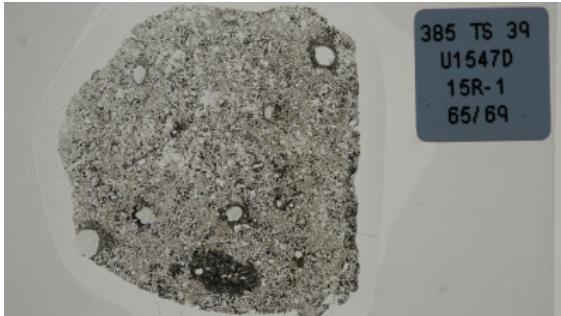
weak
[recryst]

THIN SECTION LABEL ID: 385-U1547D-15R-1-W 65/69-TSB-TS 39
Observer: Wei Xie

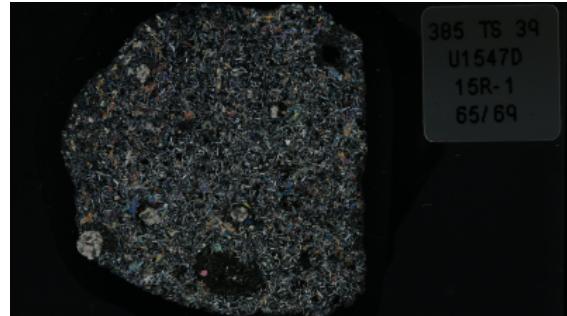
Thin section no.: 39

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 50% pl + 40% cpx + 5% pyrite TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 5%, rounded ALTERATION: slightly altered

Plane-polarized: 55204001



Cross-polarized: 55204021



Igneous Petrology

Lithology:	aphyric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	aphyric	Grain size distribution:	equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	45	5	0.5	1	euhedral	elongate	
Clinopyroxene	40	20	20	0.5	1	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	1	4	0.5	2	rounded		

Alteration

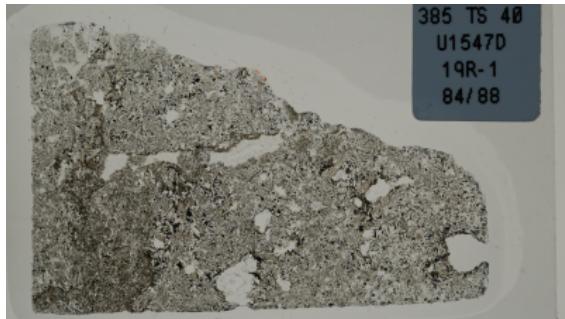
Alteration intensity:	slightly altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recryst]
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THIN SECTION LABEL ID: **385-U1547D-19R-1-W 84/88-TSB-TS 40** **Thin section no.:** 40

Observer: Wei Xie

Thin section summary: **LITHOLOGY:** clinopyroxene phricic dolerite sill **GROUNDMASS:** fine-grained, felty
GRAIN SIZE DISTRIBUTION: equigranular, 55% pl + 40% cpx + 3% pyrite **TEXTURE:** subophitic **PHENOCRYSTS:** 2% clinopyroxene **VESICLES:** 5%, sub-rounded
ALTERATION: moderately altered

Plane-polarized: 55204261



Cross-polarized: 55204311



Igneous Petrology

Lithology: clinopyroxene phricic dolerite sill **Groundmass grain size (avg.):** fine-grained [NMJ05]

Texture: subophitic **Grain size distribution:** Bimodal

Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Clinopyroxene	2	1	1	1	2	euhedral	elongate	

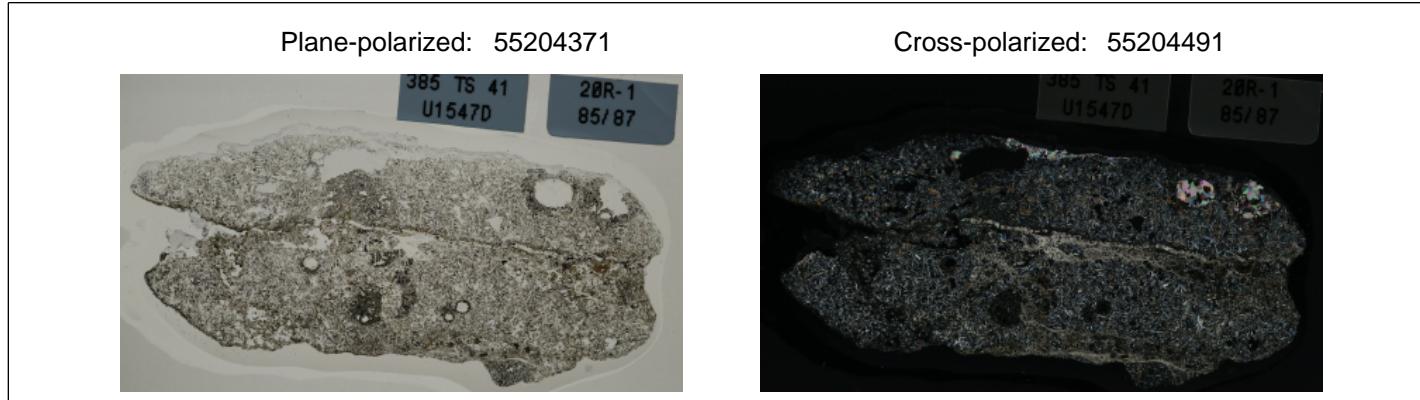
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	55	50	5	0.5	1	euhedral	elongate	
Clinopyroxene	40	20	20	0.5	1	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	3	2	0.5	3	subrounded		

Alteration

Alteration intensity: moderately altered **Texture of Alteration:** patchy **Recrystallization extent:** weak [recrust]

THIN SECTION LABEL ID:	385-U1547D-20R-1-W 85/87-TSB-TS 41	Thin section no.: 41
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: dolerite sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 60% pl + 35% cpx + 3% pyrite TEXTURE: subophitic PHENOCRYSTHS: none VESICLES: 5%, sub-rounded ALTERATION: moderately altered	



Igneous Petrology

Lithology:	dolerite sill			Groundmass grain size (avg.):	fine-grained [NMJ05]			
Texture:	subophitic			Grain size distribution:	equigranular			
Groundmass								
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	60	50	10	0.5	1	euhedral	elongate	
Clinopyroxene	35	15	20	0.5	1	subhedral	elongate	
Vesicle								
Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	2	1	1	0.5	2	subrounded		

Alteration

Alteration intensity:	moderately altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recrust]
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THIN SECTION LABEL ID: 385-U1547D-20R-2-W 112/114-TSB-TS42
Observer: Wei Xie

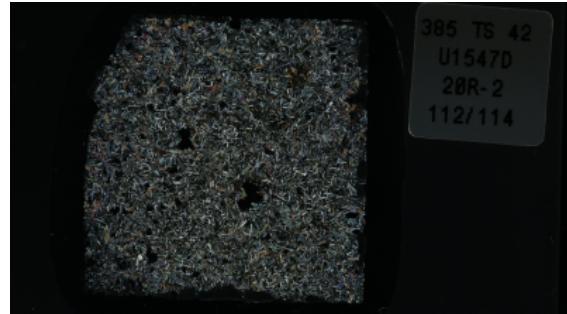
Thin section no.: 42

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 60% pl + 40% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 5%, sub-rounded ALTERATION: slightly altered

Plane-polarized: 55023801



Cross-polarized: 55023821



Igneous Petrology

Lithology:	aphyric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	aphyric	Grain size distribution:	equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	60	55	5	0.5	1	euhedral	elongate	
Clinopyroxene	40	15	25	0.5	1	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	4	1	0.5	2	subrounded		

Alteration

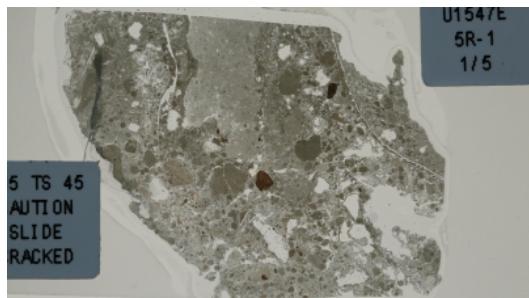
Alteration intensity:	moderately altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recryst]
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THIN SECTION LABEL ID: 385-U1547E-5R-1-W 1/5-TSB-TS 45

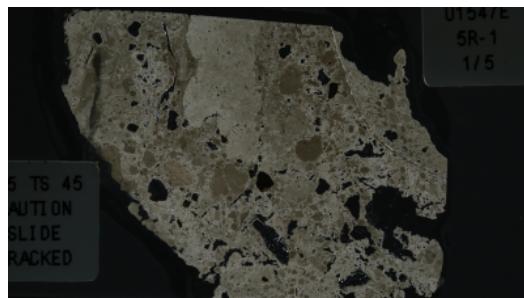
Thin section no.: 45

Observer: km

Plane-polarized: 55381181



Cross-polarized: 55381231



Sediments and Sedimentary Rock

Lithology: conglomerate

TEXTURE	Percent	CONSTITUENT	Percent
Sand		Siliciclastic Grains/Mineral	55
Silt		Authigenic Minerals	40
Clay		Biogenic Grains	5
Total Texture		Total Constituent	100

Framework grain abundance

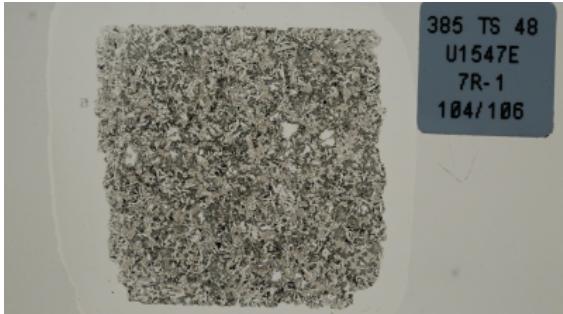
Component	%	Component	%	Component	%
Quartz		Ferromagnesium minerals		Vitric Grains	
Feldspar		Opaque Minerals		Foraminifera	1
Plagioclase		Zeolite		Radiolarians	
Rock Fragments		Pyrite		Diaotms	
Igneous Volcanic Fragments	4	Quartz (Authigenic)		Organic Debris	
Sedimentary Fragments	50	Calcite	40	Plant Debris	
Matrix (Silt and Clay)		Dolomite		Fish Remains	
Biotite		Porosity		Other	
Clay Minerals					

THIN SECTION LABEL ID: 385-U1547E-7R-1-W 104/106-TSB-TS 48 **Thin section no.:** 48

Observer: Wei Xie

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 50% pl + 50% cpx TEXTURE: aphyric PHENOCRYSTS: none VESICLES: 0.5%, sub-angular ALTERATION: moderately altered

Plane-polarized: 55381331



Cross-polarized: 55381351



Igneous Petrology

Lithology: aphyric basalt sill **Groundmass grain size (avg.):** fine-grained [NMJ05]

Texture: subophitic **Grain size distribution:** equigranular

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	50	45	5	0.5	1	euhedral	elongate	
Clinopyroxene	50	20	30	0.5	2	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	0.5	0.3	0.2	0.5	1	subangular		

Alteration

Alteration intensity: moderately altered **Texture of Alteration:** patchy **Recrystallization extent:** weak [recryst]

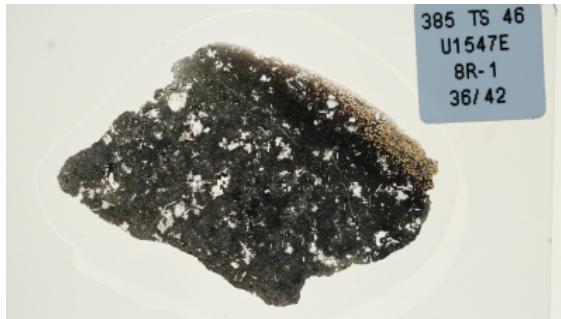
THIN SECTION LABEL ID: 385-U1547E-8R-1-W 36/42-TSB-TS 46

Thin section no.: 46

Observer: Wei Xie

Thin section summary: Domain 1, LITHOLOGY: palagonite margin Domain 2, LITHOLOGY: plagioclase clinopyroxene phryic basalt sill GROUNDMASS: fine-grained GRAIN SIZE DISTRIBUTION: Bimodal TEXTURE: porphyritic PHENOCRYSTS: 10% plagioclase + 5% clinopyroxene VESICLES: none ALTERATION: intensively altered

Plane-polarized: 55381251



Cross-polarized: 55381271



Igneous Petrology

Lithology: palagonite

Groundmass grain size (avg.):

Texture:

Grain size distribution:

Igneous Petrology

Lithology: plagioclase clinopyroxene phryic basalt sill

Groundmass grain size (avg.): fine-grained [NMJ05]

Texture: porphyritic

Grain size distribution: Bimodal

Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	10	8	2	0.5	1	euhedral	elongate	
Clinopyroxene	5	1	4	0.5	2	euhedral	elongate	

Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	40	10	30	1	0.3	euhedral	elongate	
Clinopyroxene	35	0	35					

Alteration

Alteration intensity: intensely altered

Texture of Alteration

coating

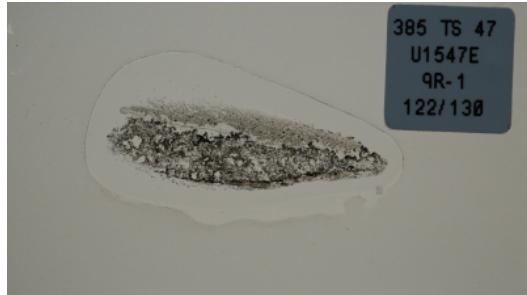
Recrystallization extent: strong [recrust]

THIN SECTION LABEL ID: 385-U1547E-9R-1-W 122/130-TSB-TS 47

Thin section no.: 47

Observer: km

Plane-polarized: 55381291



Cross-polarized: 55381311



Sediments and Sedimentary Rock

Lithology:

TEXTURE	Percent	CONSTITUENT	Percent
Sand		Siliciclastic Grains/Mineral	
Silt		Authigenic Minerals	70
Clay		Biogenic Grains	
Total Texture		Total Constituent	100

THIN SECTION LABEL ID: 385-U1547E-20R-1-W 29/35-TSB-TS 49
Observer: Wei Xie

Thin section no.: 49

Thin section summary: LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 45% pl + 40% cpx TEXTURE: porphyritic PHENOCRYSTS: 10% clinopyroxene VESICLES: 5%, sub-rounded, fille with fine-grained zeolite ALTERATION: moderately altered

Plane-polarized: 55567191



Cross-polarized: 55567261



Igneous Petrology

Lithology:	clinopyroxene phric basalt sill	Groundmass grain size (avg.):	fine-grained [NMJ05]
Texture:	porphyritic	Grain size distribution:	Bimodal

Phenocrysts	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Clinopyroxene	10	5	5	0.8	1.5	euhedral	elongate	

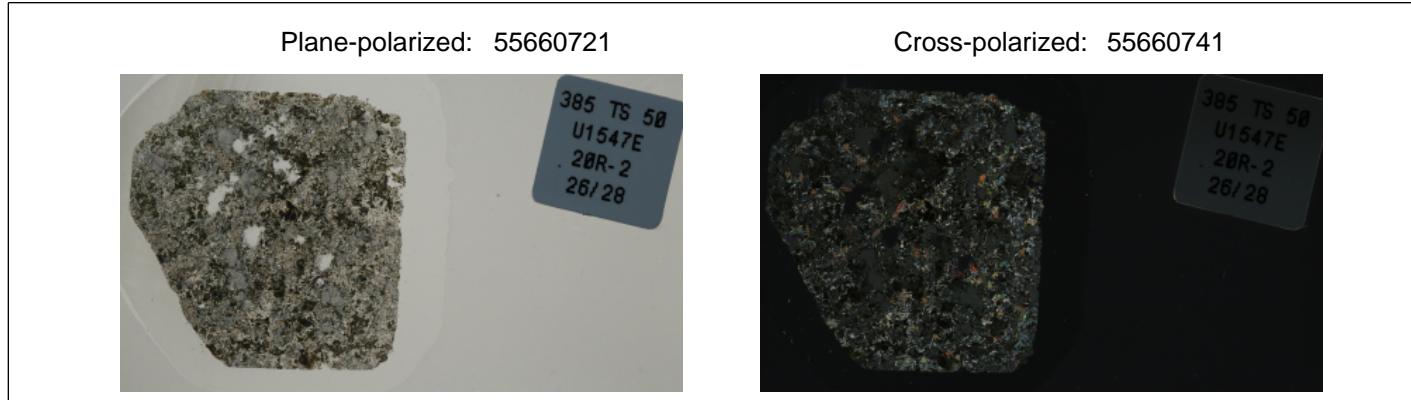
Groundmass	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	45	35	10	0.2	0.6	euhedral	elongate	
Clinopyroxene	40	10	30	0.2	0.6	subhedral	elongate	

Vesicle	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	5	0	5	0.5	2	subrounded		

Alteration

Alteration intensity:	moderately altered	Texture of Alteration	patchy	Recrystallization extent:	weak [recrust]
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THIN SECTION LABEL ID:	385-U1547E-20R-2-W 26/28-TSB-TS 50	Thin section no.: 50
Observer:	Wei Xie	
Thin section summary:	LITHOLOGY: aphyric basalt sill GROUNDMASS: fine-grained, felty GRAIN SIZE DISTRIBUTION: equigranular, 45% pl + 40% cpx TEXTURE: porphyritic PHENOCRYSTS: 5% clinopyroxene VESICLES: 10%, sub-rounded, fille with fine-grained zeolite ALTERATION: highly altered	



Igneous Petrology

Lithology:	clinopyroxene phric basalt sill			Groundmass grain size (avg.):	fine-grained [NMJ05]			
Texture:	porphyritic			Grain size distribution:	Bimodal			
Phenocrysts								
	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Clinopyroxene	10	5	5	0.8	1	euhedral	elongate	
Groundmass								
	Original (%)	Present (%)	Replaced (%)	Size min. (mm)	Size max. (mm)	Shape	Habit	Comments
Plagioclase	45	25	20	0.2	0.5	euhedral	elongate	
Clinopyroxene	40	30	10	0.2	0.4	subhedral	elongate	
Vesicle								
	Original (%)	Empty (%)	Filled (%)	Size min. (mm)	Size max. (mm)	Shape	Density	Comments
	10	2	8	0.5	2	subrounded		

Alteration

Alteration intensity:	highly altered	Texture of Alteration	patchy	Recrystallization extent:	strong [recrust]
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